Search Notes

_	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/775,911	MORGAN, DENNIS R.
	Examiner	Art Unit
	Christina Y. Leung	2613

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SEARCH NOT (INCLUDING SEARCH)		)
	DATE	EXMR
Updated EAST text search (see search history)	11/12/2007	/CU
IEEE database search (terms included PMD, least mean square, newton, filter)	11/12/2007	/CU
Optics Letters database search (terms included PMD, least mean square, newton, filter)	11/12/2007	/CL/
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